

INTERNATIONAL STANDARD



**Twinax cables for digital communications –
Part 1-1: Time domain test methods for twinax cables for digital
communications – General requirements**

IEC 62783-1-1:2022

<https://standards.iteh.ai/catalog/standards/sist/01ddb869-a1a5-4239-9246-9adf9a9066c9/iec-62783-1-1-2022>



THIS PUBLICATION IS COPYRIGHT PROTECTED

Copyright © 2022 IEC, Geneva, Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either IEC or IEC's member National Committee in the country of the requester. If you have any questions about IEC copyright or have an enquiry about obtaining additional rights to this publication, please contact the address below or your local IEC member National Committee for further information.

IEC Secretariat
3, rue de Varembe
CH-1211 Geneva 20
Switzerland

Tel.: +41 22 919 02 11
info@iec.ch
www.iec.ch

About the IEC

The International Electrotechnical Commission (IEC) is the leading global organization that prepares and publishes International Standards for all electrical, electronic and related technologies.

About IEC publications

The technical content of IEC publications is kept under constant review by the IEC. Please make sure that you have the latest edition, a corrigendum or an amendment might have been published.

IEC publications search - webstore.iec.ch/advsearchform

The advanced search enables to find IEC publications by a variety of criteria (reference number, text, technical committee, ...). It also gives information on projects, replaced and withdrawn publications.

IEC Just Published - webstore.iec.ch/justpublished

Stay up to date on all new IEC publications. Just Published details all new publications released. Available online and once a month by email.

IEC Customer Service Centre - webstore.iec.ch/csc

If you wish to give us your feedback on this publication or need further assistance, please contact the Customer Service Centre: sales@iec.ch.

IEC Products & Services Portal - products.iec.ch

Discover our powerful search engine and read freely all the publications previews. With a subscription you will always have access to up to date content tailored to your needs.

Electropedia - www.electropedia.org

The world's leading online dictionary on electrotechnology, containing more than 22 300 terminological entries in English and French, with equivalent terms in 19 additional languages. Also known as the International Electrotechnical Vocabulary (IEV) online.

[IEC 62783-1-1:2022](https://standards.iteh.ai/catalog/standards/sist/01ddb869-a1a5-4239-9246-9adf9a9066c9/iec-62783-1-1-2022)

<https://standards.iteh.ai/catalog/standards/sist/01ddb869-a1a5-4239-9246-9adf9a9066c9/iec-62783-1-1-2022>

INTERNATIONAL STANDARD



**Twinax cables for digital communications –
Part 1-1: Time domain test methods for twinax cables for digital
communications – General requirements**

IEC 62783-1-1:2022

<https://standards.iteh.ai/catalog/standards/sist/01ddb869-a1a5-4239-9246-9adf9a9066c9/iec-62783-1-1-2022>

INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

ICS 33.120.20

ISBN 978-2-8322-3853-0

Warning! Make sure that you obtained this publication from an authorized distributor.

CONTENTS

FOREWORD.....	3
INTRODUCTION.....	5
1 Scope.....	6
2 Normative references	6
3 Terms, definitions and abbreviated terms	6
3.1 Terms and definitions.....	6
3.2 Abbreviated term	8
4 Test equipment.....	8
4.1 Measurement equipment.....	8
4.2 Coaxial cables (test leads)	8
4.3 Test fixtures	9
4.4 Termination resistors	9
4.5 Through calibration kit (Thru kit)	9
5 Test conditions	9
6 Measurement methods	10
6.1 Calibration	10
6.2 De-skew.....	10
6.3 Establish the reference plane for the TDR measurement.....	10
6.4 Establish the reference plane for the TDT measurement	11
6.5 Measurement.....	11
7 Test report.....	11
Bibliography.....	12
Figure 1 – Test schematic diagram for open location of the test fixture	10
Figure 2 – Test schematic diagram for TDT measurement	11

INTERNATIONAL ELECTROTECHNICAL COMMISSION

TWINAX CABLES FOR DIGITAL COMMUNICATIONS –

**Part 1-1: Time domain test methods for twinax cables
for digital communications – General requirements**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

IEC 62783-1-1 has been prepared by subcommittee 46C: Wires and symmetric cables, of IEC technical committee 46: Cables, wires, waveguides, RF connectors, RF and microwave passive components and accessories. It is an International Standard.

The text of this International Standard is based on the following documents:

Draft	Report on voting
46C/1191/CDV	46C/1218/RVC

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/standardsdev/publications.

A list of all parts in the IEC 62783 series, published under the general title *Twinax cables for digital communications*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under webstore.iec.ch in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

IMPORTANT – The "colour inside" logo on the cover page of this document indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

ITEH STANDARD PREVIEW
(standards.iteh.ai)

IEC 62783-1-1:2022

<https://standards.iteh.ai/catalog/standards/sist/01ddb869-a1a5-4239-9246-9adf9a9066c9/iec-62783-1-1-2022>

INTRODUCTION

This document specifies the general requirements of time domain test methods for twinax cables used in information technology systems. The high data rates of these systems need both frequency domain test methods and time domain test methods to ensure signal integrity.

Time domain here refers to time domain analysis or display(s), as defined by an X-Y graph where the X-axis is either time or electrical length of device under test (DUT), and the Y-axis is magnitude (voltage, impedance or reflection coefficient). Time domain display provides a direct view of the DUT's characteristics. In addition, time domain method gives information concerning the reflection and transmission of the DUT and it can show the effect of each discontinuity as a function of time or distance.

iTeh STANDARD PREVIEW
(standards.iteh.ai)

[IEC 62783-1-1:2022](https://standards.iteh.ai/catalog/standards/sist/01ddb869-a1a5-4239-9246-9adf9a9066c9/iec-62783-1-1-2022)

<https://standards.iteh.ai/catalog/standards/sist/01ddb869-a1a5-4239-9246-9adf9a9066c9/iec-62783-1-1-2022>

TWINAX CABLES FOR DIGITAL COMMUNICATIONS –

Part 1-1: Time domain test methods for twinax cables for digital communications – General requirements

1 Scope

This part of IEC 62783-1 specifies time domain test methods, parameters and requirements for fixtures for twinax cables (known also as twin-axial cables or twin-coaxial cables) used in digital communication systems. The methods and fixtures facilitate measurements of differential and common mode transmission parameters as well as single-ended mode parameters.

This document is applicable to twinax cables and also to symmetric cables with pitch.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-726, *International Electrotechnical Vocabulary (IEV) – Part 726: Transmission lines and waveguides* (available at www.electropedia.org)

IEC 62783-1, *Twinax cables for digital communications – Part 1: Generic specification*

3 Terms, definitions and abbreviated terms

3.1 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 60050-726, IEC 62783-1 and the following apply.

ISO and IEC maintain terminology databases for use in standardization at the following addresses:

- ISO Online browsing platform: available at <http://www.iso.org/obp>
- IEC Electropedia: available at <http://www.electropedia.org/>

3.1.1

time domain reflectometer TDR

instrument intended to measure reflections and transmissions of step pulse waves along the device under test (DUT), the individual reflections being measured and displayed as a function of time or distance

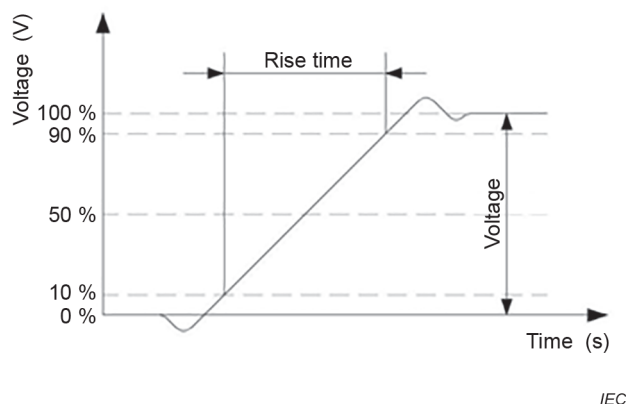
3.1.2

rise time

time interval between the instants at which the magnitude of the pulse first reaches a specified lower value and then a specified upper value

Note 1 to entry: In general, ignoring overshoot and undershoot, the lower level and upper level of pulse magnitude are specified at 10 % to 90 %, unless otherwise specified.

Note 2 to entry: Rise time is expressed in ps.



3.1.3

differential mode characteristic impedance

differential mode impedance

Z_{diff}

impedance between two wires of the same pair, with a specified rise time within the steady state time or length range, when the differential mode signals with opposite polarities and equal amplitudes are injected into the cable pair

Note 1 to entry: Differential mode characteristic impedance is expressed in ohm.

3.1.4

single-ended characteristic impedance

single-ended impedance

impedance between one wire of a symmetrical pair and the reference-ground plane when a single-ended signal is injected into this wire

Note 1 to entry: Single-ended characteristic impedance is expressed in ohm.

Note 2 to entry: The reference-ground plane generally comprises screening of the cable.

3.1.5

differential mode propagation delay

differential mode delay

time required for the transmission of differential mode pulse signal between two specified points at the specified rise time along the cable

Note 1 to entry: Differential mode propagation delay is expressed in ns/m.

3.1.6

common mode propagation delay

common mode delay

time required for the transmission of common mode pulse signal between two specified points at the specified rise time along the cable

Note 1 to entry: Common mode propagation delay is expressed in ns/m.

3.1.7

inter-pair skew

difference in propagation delay of any two pairs in the cable

Note 1 to entry: Inter-pair skew is expressed in ns/m.

Note 2 to entry: Inter-pair skew is applicable to differential mode inter-pair skew and common mode inter-pair skew.

3.1.8

intra-pair skew

signal transmission time difference per unit length between the two wires of the cable pair of the DUT in differential mode or in common mode when a differential mode signal or common mode signal at the specified rise time is transmitted through the cable pair of the DUT

Note 1 to entry: Intra-pair skew is usually expressed in ps/m.

Note 2 to entry: In the event of unbalance of coupled wires as in twinax cables, differential to common mode conversion in frequency domain shall be also considered.

3.1.9

through calibration kit

Thru kit

kit having the same quality and design as the test fixtures with the electrical length being twice that of the single fixture

3.2 Abbreviated terms

Abbreviated term	Full term
CUT	cable under test
DUT	device under test
IDFT	inverse discrete Fourier transformation
PCB	printed circuit board
TDR measurement	time domain reflection measurement
TDT measurement	time domain transmission measurement
VNA	vector network analyser

<https://standards.iteh.ai/catalog/standards/sist/01ddb869-a1a5-4239-9246-9adf9a9066c9/iec-62783-1-1-2022>

4 Test equipment

4.1 Measurement equipment

A sampling oscilloscope with two dual-channel TDR modules which can both generate and receive the step pulses are preferred, or one dual-channel TDR module used to generate the step pulses and one sampling module used to receive the step pulse may be used.

The rise time of the TDR module should cover the requirements of the cable under test (CUT).

Another option of measurement equipment is a 4-port vector network analyser with time domain analysis function if its precision can meet the test requirements. The VNA shall have the capability of mathematical baluns and can perform full 4-port calibration, at the same time the VNA shall have the time domain analysis function by using inverse discrete Fourier transformation (IDFT). The description of inverse discrete Fourier transformation (IDFT) can be found in IEC 62153-1-1.

Two 2-channel TDR modules or a 4-port VNA is a minimum requirement for a multi-pair measurement, in order to minimize the re-connection of the CUT for each pair combination, the use of an RF switching unit is also recommended.

4.2 Coaxial cables (test leads)

Four pieces of low loss, phase stable coaxial cables with an impedance of 50 Ω are used to connect the fixtures to the measurement equipment. The cables' bandwidth should meet the requirement of CUT.